

## Claims

What is claimed is:

- 1 1. An apparatus for projecting fringes onto a surface of an object, said apparatus comprising:
  - 2 a) two sources of radiation having a spectral distribution;
  - 3 b) a collimator in optical communication with said two sources, said collimator
  - 4 generating two substantially collimated beams of broadband radiation;
  - 5 c) a diffractive grating in optical communication with said collimator; and
  - 6 d) a lens in optical communication with said diffractive grating, wherein said lens
  - 7 generates two images of radiation having a spatial distribution of spectral regions.
- 1 2. The apparatus of claim 1 wherein each of said spectral regions of one of said sources is
- 2 separated from a respective spectral region of the other of said sources by a distance
- 3 proportional to the respective wavelength of said spectral regions.
- 1 3. The apparatus of claim 2 wherein said distance is linearly proportional to said wavelength
- 2 of said spectral regions.
- 1 4. The apparatus of claim 2 wherein said distance comprises a midpoint equidistant from each
- 2 of two respective spectral regions and wherein said midpoint is fixed.
- 1 5. The apparatus of claim 1 wherein said two sources of radiation are coherent with respect to
- 2 one another.
- 1 6. The apparatus of claim 1 wherein said two sources of radiation have a spectral distribution
- 2 that is narrowband.
- 1 7. The apparatus of claim 1 further comprising a detector for determining three-dimensional
- 2 position information of a point on said surface of said object.
- 1 8. The apparatus of claim 1 wherein the two sources of radiation are generated from a single
- 2 source of radiation.

- 1 9. The apparatus of claim 1 further comprising a translator coupled to said diffractive grating,  
2 said translator shifting the relative phase of one of said spectral regions with respect to the  
3 other of said spectral regions.
- 1 10. A method for mitigating the effects of speckle on a measurement of a point on a surface of  
2 an object, said method comprising the steps of:
- 3 a) generating a coherent fringe pattern;
- 4 b) projecting the coherent fringe pattern along an optical path onto the surface of the  
5 object such that the fringe pattern substantially grazes the surface of the object;  
6 and
- 7 c) detecting the fringe pattern and the speckle in an image of the surface of the  
8 object, wherein a normal to the surface of the object is substantially orthogonal to  
9 said optical path.
- 1 11. The method of claim 10 wherein the coherent fringe pattern substantially grazes the surface  
2 of the object at an angle between 0 and 45 degrees with respect to the surface of the object.
- 1 12. The method of claim 10 further comprising the step of providing two sources of radiation.
- 1 13. The method of claim 12 wherein the two sources are positioned above the surface of the  
2 object.
- 1 14. The method of claim 12 wherein the two sources are substantially vertically aligned along  
2 the normal to the surface of the object.
- 1 15. The method of claim 10 wherein the fringe pattern is generated by two sources.
- 1 16. The method of claim 15 wherein the two sources are coherent with respect to one another.
- 1 17. The method of claim 15 wherein the two sources are laser sources.
- 1 18. The method of claim 15 wherein the two sources are generated by splitting a single source.
- 1 19. A method for projecting fringes onto a surface of an object, said method comprising the  
2 steps of:

- a) providing two sources of radiation separated by a distance, each of said sources having a spectral distribution and being coherent with respect to the other of said sources;
- b) illuminating said point on said surface of said object with said radiation from each of said sources;
- c) moving one of said sources relative to the other of said sources; and
- d) detecting radiation scattered by said point on said surface of said object.

20. The method of claim 19 further comprising the step of changing the phase of a spectral component in said spectral distribution from one of said sources relative to the phase of a respective spectral component in said spectral distribution from the other of said sources as measured at said point on said surface of said object.